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INFORMATION DISCLOSURE CITATION IN AN APPLICATION

ATTY. DOCKET NO. 4006-284	U.S. PATENT APPLICATION NO. 10/810,660
ADDITIONAL	

Wen-Jian LIN

(PTO-1449)				FILING DATE		GROUP		
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)			ATTY. DOCKET NO. 4006-284		U.S. PATENT APPLICATION NO. 10/810,660			
				APPLICANT Wen-Jian LIN				
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